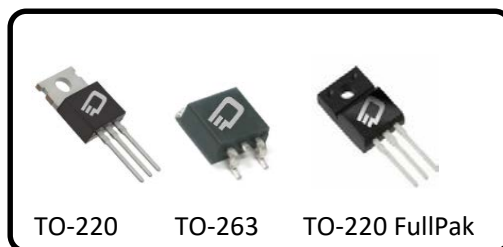


650V, 380mΩ, 11.2 A Super Junction Power MOSFET

Ordering Information

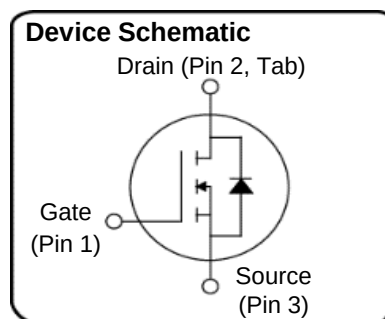
Part Number	Package Option
D3S380N65B-U	TO-220
D3S380N65E-T	TO-263
D3S380N65F-U	TO-220 FullPak (FP)



Description

+FET[™] is an advanced Super Junction Power MOSFET offering excellent efficiency through low $R_{DS(ON)}$ and low gate charge.

+FET[™] is a rugged device with precision charge balance implementation designed for demanding uses such as enterprise power computing power supplies, motor control, lighting and other challenging power conversion applications.



Features

- LOW $R_{DS(ON)}$
- FAST SWITCHING
- HIGH E_{AS}
- REL TEST SPEC: JESD-22
- LOW OUTPUT CAPACITANCE

Benefits

- LOW CONDUCTION LOSSES
- HIGH EFFICIENCY
- EXCELLENT AVALANCHE PERFORMANCE

Table 1 Key Performance Parameters

Parameters	Value	Unit
$V_{DS} @ T_{J \max}$	710	V
$R_{DS(on), \max}$	<380	mΩ
Q_g, typ	16	nC
$I_D @ 25^\circ\text{C}$	11.2	A
C_{oss}	35	pf

Applications

- POWER FACTOR CORRECTION
- SERVER POWER SUPPLIES
- TELECOM POWER SUPPLIES
- INVERTERS
- MOTOR CONTROL

Table of contents

Description-----	1
Maximum ratings-----	3
Thermal characteristics-----	3
Electrical characteristic-----	4
Electrical characteristics diagrams-----	6
Test Circuit & Waveform-----	11
Revision-----	16

@ $T_J = 25^\circ\text{C}$,unless otherwise specified

Table 2 Maximum ratings

Parameter	Symbol	Values				Unit	Note/Test Condition
		Min.	Typ.	Max.			
				220, 263 & 247	220FP		
Continuous drain current(1)	I _D			11.2	7.0	A	T _C = 25°C
				7.1	4.4		T _C = 100°C
Pulsed drain current(2)	I _{D,pulse}			44.7	28.0	A	T _C = 25°C
Avalanche energy, single pulse	E _{AS}			202	202	mJ	I _D =1.8A, V _{DD} =50V
Avalanche energy, repetitive	E _{AR}			0.5	0.5	mJ	I _D =1.8A, V _{DD} =50V
Avalanche current, repetitive	I _{AR}			1.8	1.8	A	
MOSFET dv/dt ruggedness	dv/dt			50	50	V/ns	V _{DS} =...480V
Gate source voltage	V _{GS}	-30		30	30	V	static
		-30		30	30		AC (f > 1HZ)
Power dissipation for TO-220	P _{tot}			114	44	W	T _C = 25°C
Operating and storage temperature	T _j , T _{stg}	-55		150	150	°C	
Mounting torque				60		Ncm	M3 and M3.5 screws
					50		M3 screws
Continuous diode forward current	I _S			11.2	7.0	A	T _C = 25°C
Diode pulsed current	I _{S,pulse}			44.7	28.0	A	T _C = 25°C
Reverse diode dv/dt(3)	dv/dt			15	15	V/ns	V _{DS} =...480V, I _{SD} <I _D T _J = 25°C
Maximum diode commutation speed	dif/dt			500	500	A/us	

Table 3 Thermal characteristics

Parameter	Symbol	Values				Unit	Note/Test Condition
		Min.	Typ.	Max.			
				220, 263 & 247	220FP		
Thermal resistance, Junction-case	R _{thJC}			1.3	3.1	°C/W	
Thermal resistance, Junction-ambient	R _{thJA}			55.8	60	°C/W	Leaded
Soldering temperature, wavesoldering only allowed at leads	T _{sold}			260	260	°C	1.6mm form case for 10s

Table 4 Static characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Drain to source breakdown voltage	$V_{(BR)DSS}$	650			V	$V_{GS}=0V, I_D=1mA$
Gate threshold voltage	$V_{GS(TH)}$	2.3	3.2	4.5	V	$V_{DS}=V_{GS}, I_D=52.6\mu A$
Zero gate voltage drain current	I_{DSS}			1	μA	$V_{DS}=650V, V_{GS}=0V, T_J = 25^\circ C$
				40		$V_{DS}=650V, V_{GS}=0V, T_J = 150^\circ C$
Gate to source leakage current	I_{GSS}			100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$
Drain-source on-state resistance	$R_{DS(on)}$		320	380	m Ω	$V_{GS}=10V, I_D=5.6A, T_J = 25^\circ C$
			860		m Ω	$V_{GS}=10V, I_D=5.6A, T_J = 150^\circ C$
Gate resistance	R_G		1.1		Ω	Scaf-F

Table 5 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}		618		pF	$V_{GS}=0V, V_{DS}=100V, f=1MHz$
Output capacitance	C_{oss}		26.2		pF	
Reverse transfer capacitance	C_{rss}		4.8		pF	
Effective output capacitance, energy related 1	$C_{o(er)}$		63		pF	$V_{DS}=0...480V, V_{GS}=0V$
Effective output capacitance, time related 2	$C_{o(tr)}$		137		pF	$I_D=constant, V_{DS}=0...480V, V_{GS}=0V$
Turn on delay time	$t_{d(on)}$		5		ns	$V_{DD}=400V, I_D=5.6A, R_G=1.0\Omega, V_{GS}=10V$
Rising time	t_r		21		ns	
Turn off delay time	$t_{d(off)}$		20		ns	
Fall time	t_f		24		ns	

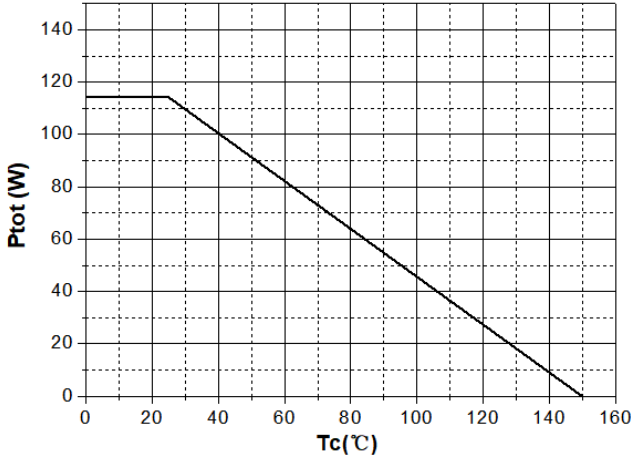
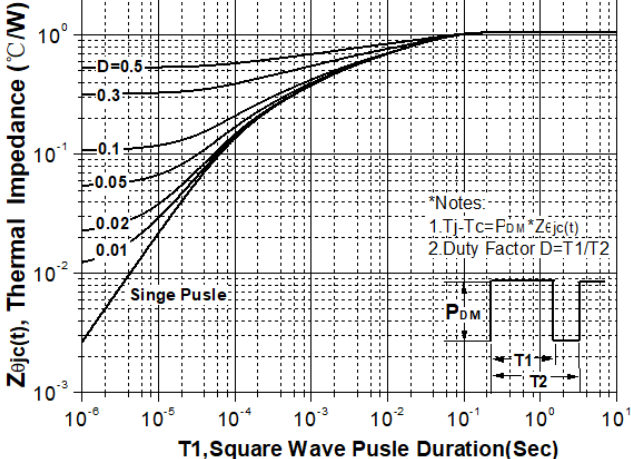
Table 6 Gate charge characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Total gate charge	Q_g		15.4		nC	$V_{DD}=480V, V_{GS}=0 \text{ to } 10V, I_D=5.6A$
Gate-source charge	Q_{gs}		4.1		nC	
Gate-drain charge	Q_{gd}		6.2		nC	
Gate plateau voltage	$V_{plateau}$		5.0		V	

Table 7 Reverse diode characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Typ.	Max.		
Diode forward voltage	V_{SD}		0.84	0.96	V	$I_F=11.2A, V_{GS}=0V, T_J = 25^{\circ}C$
Reverse recovery time	t_{rr}		232		ns	$I_F=11.2A, dI_F/dt=100A/us$
Reverse recovery charge	Q_{rr}		2.0		uC	
Peak reverse recovery current	I_{rrm}		16.6		A	

Table 8 Thermal Performance

Power dissipation (TO220, TO263 & TO247)	Max. transient thermal impedance (TO220, TO263 & TO247)
	
$P_{tot}=f(T_C)$	$Z_{thJC}=f(t_p)$; parameter: $D=t_p/T$

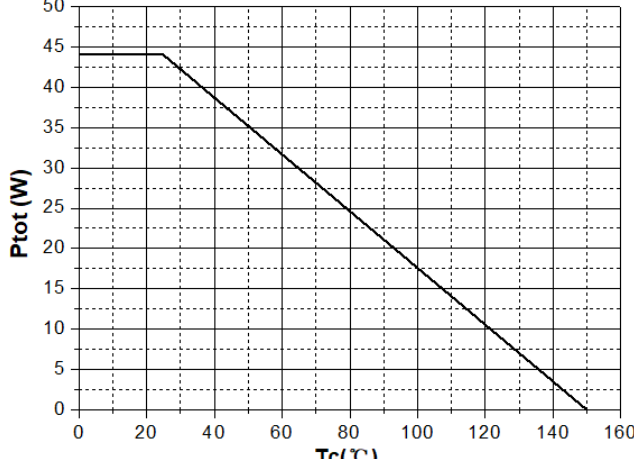
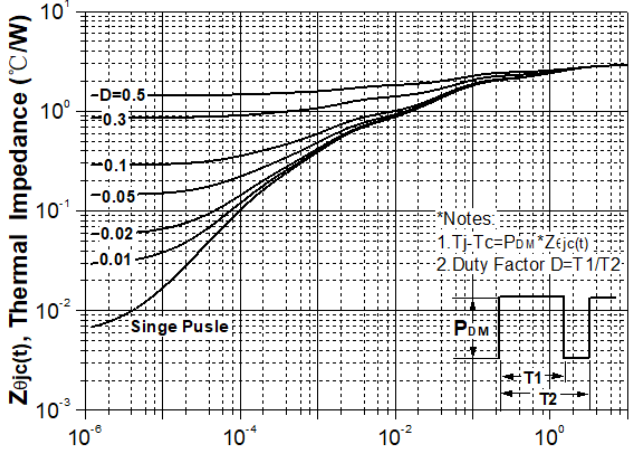
Power dissipation (TO220F)	Max. transient thermal impedance (TO220F)
	
$P_{tot}=f(T_C)$	$Z_{thJC}=f(t_p)$; parameter: $D=t_p/T$

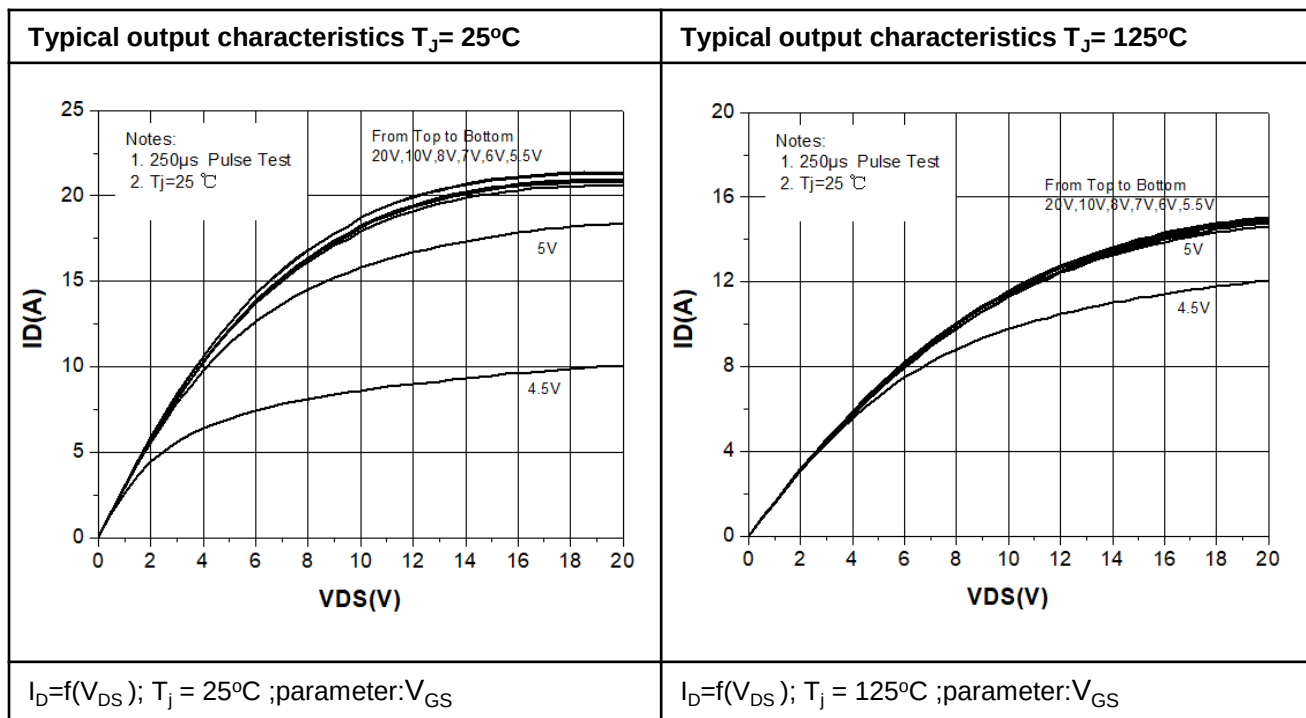
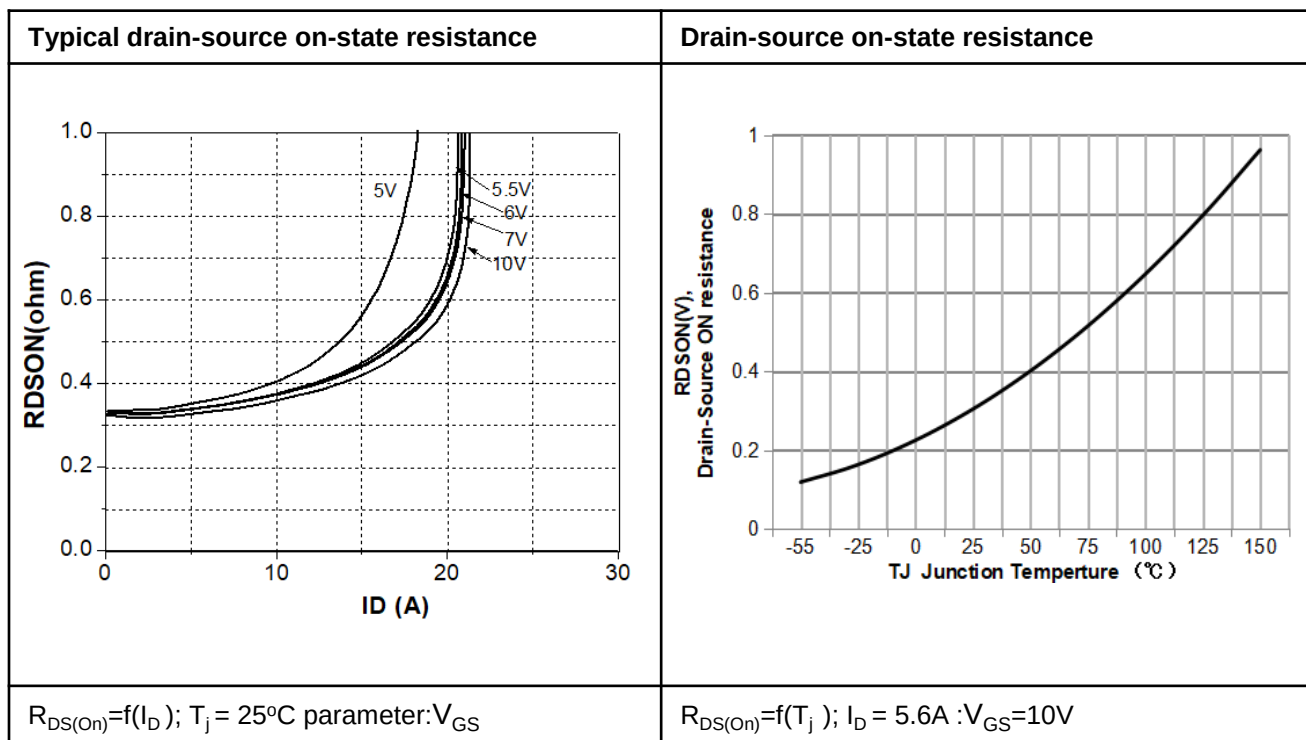
Table 9 Output Characteristics

Table 10 Drain Source Resistance


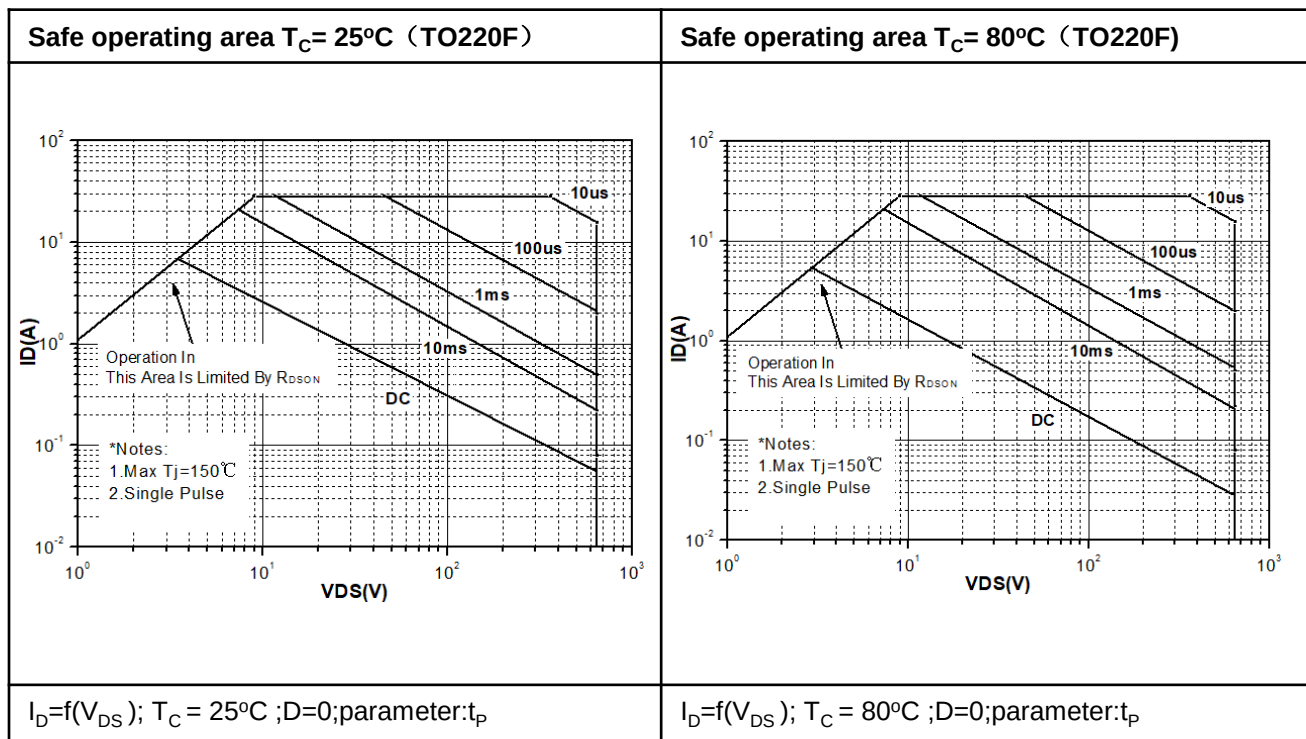
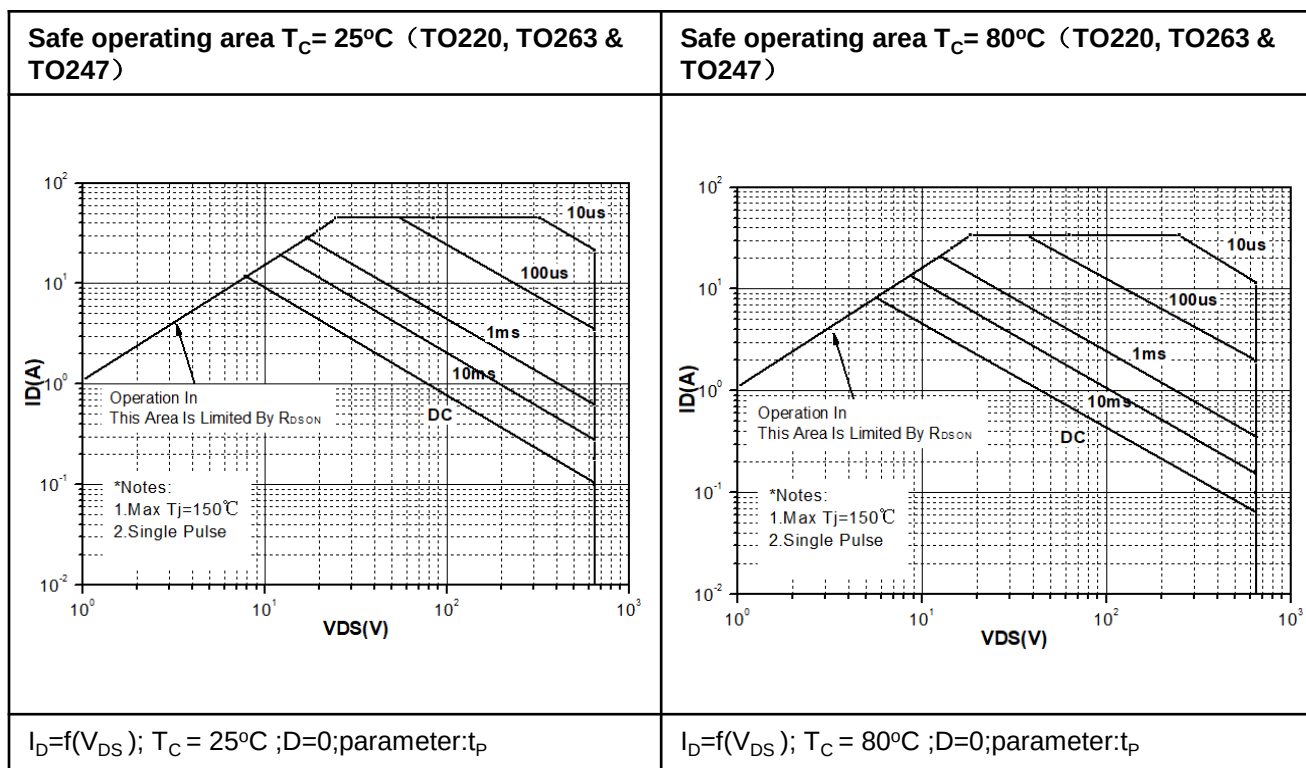
Table 12 Safe Operating Area


Table 12 Capacitances and Gate Charge

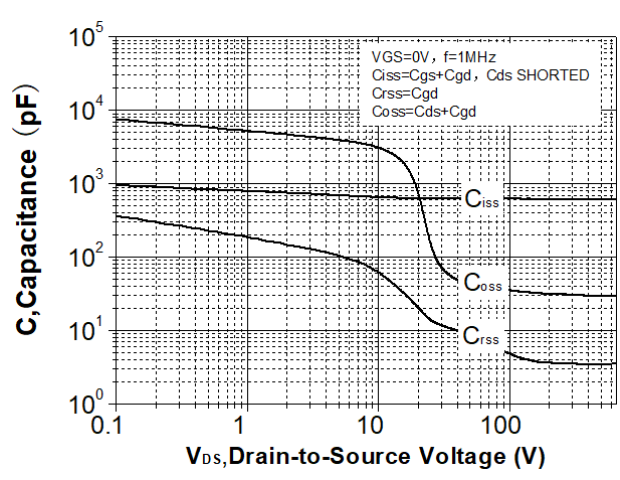
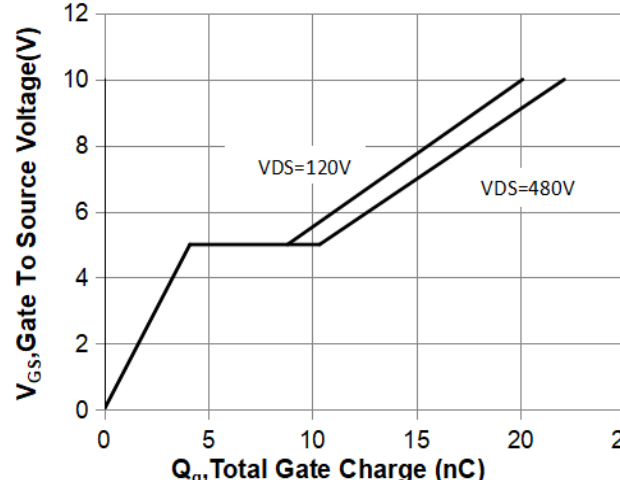
Typical Capacitances	Typical Gate charge
 $V_{GS}=0V, f=1MHz$ $C_{iss}=C_{gs}+C_{gd}, C_{ds} \text{ SHORTED}$ $C_{rss}=C_{gd}$ $C_{oss}=C_{ds}+C_{gd}$	
$V_{gs}=0v$, Freq.= 1MHz	$I_D=f(Q_{gate})$; $I_D = 7.1A$ pulsed; parameter: V_{DD}

Table 13 Diode Characteristics and Avalanche Energy

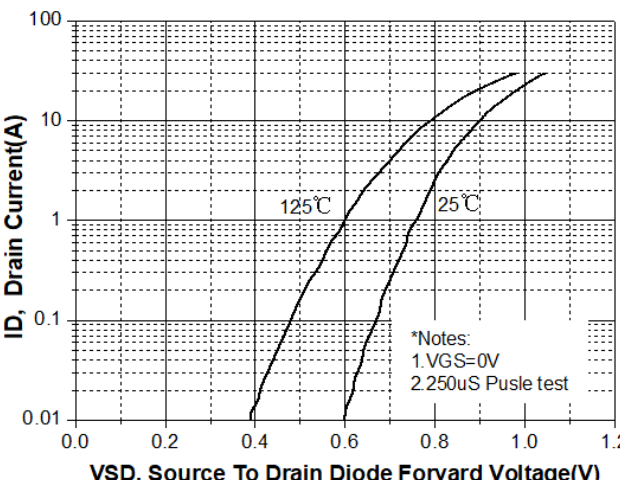
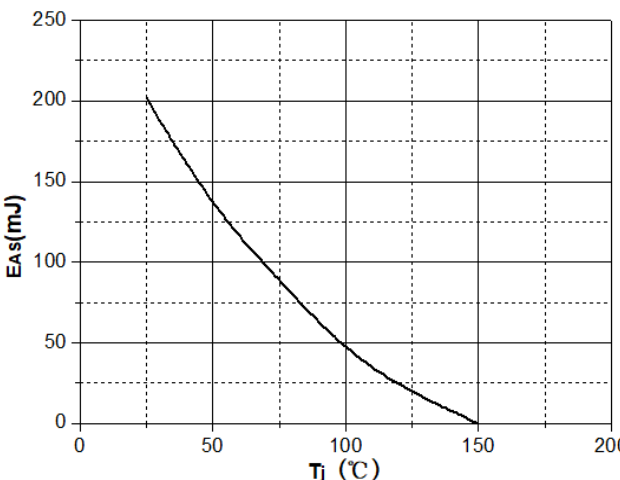
Forward characteristics of reverse diode	Avalanche energy
 $I_D=f(V_{SD})$; parameter: T_j	
$I_F=f(V_{SD})$; parameter: T_j	$E_{AS}=f(T_j)$; $I_D = 1.8A$; $V_{DD} = 50V$

Table 16 Breakdown Voltage and Transfer Characteristics

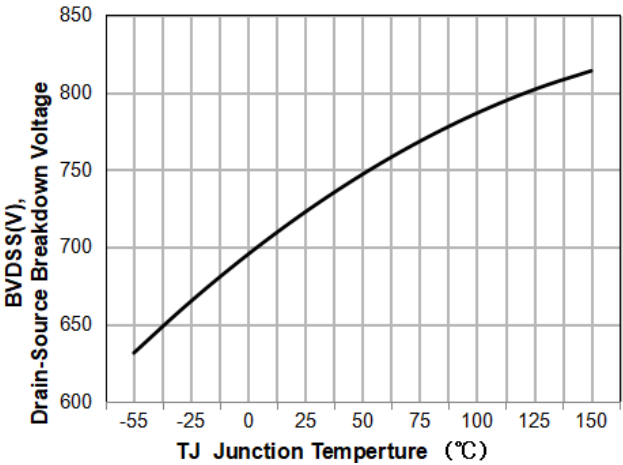
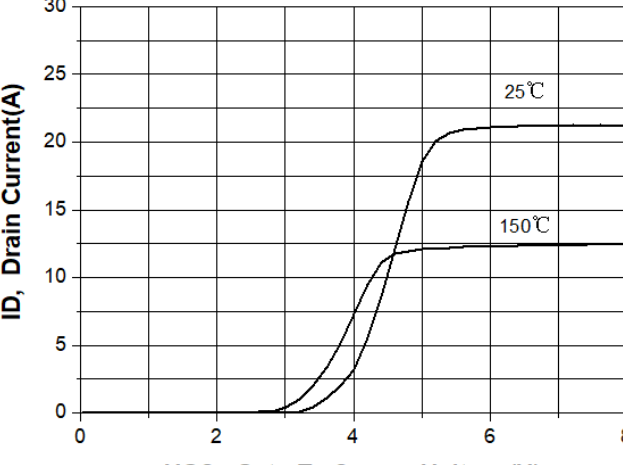
Drain-source breakdown voltage	Transfer Characteristics
 BVDSS(V), Drain-Source Breakdown Voltage TJ Junction Temperature (°C)	 ID, Drain Current(A) VGS, Gate-To-Source Voltage(V) 25°C 150°C
$V_{BR(DSS)} = f(T_j); I_D = 0.25mA$	$I_D = f(V_{GS}); V_{DS} > 2 I_D R_{DS(On)max}; \text{parameter: } T_j$

Table 15 Diode Recovery Characteristic

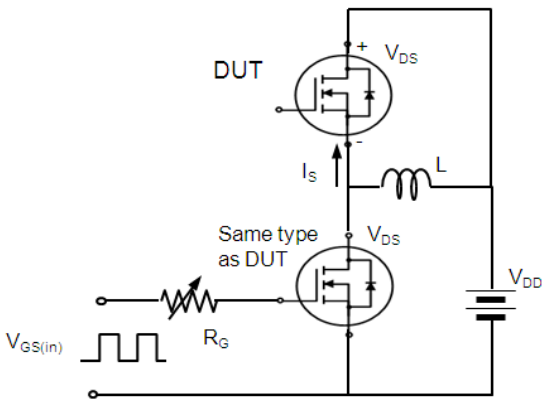
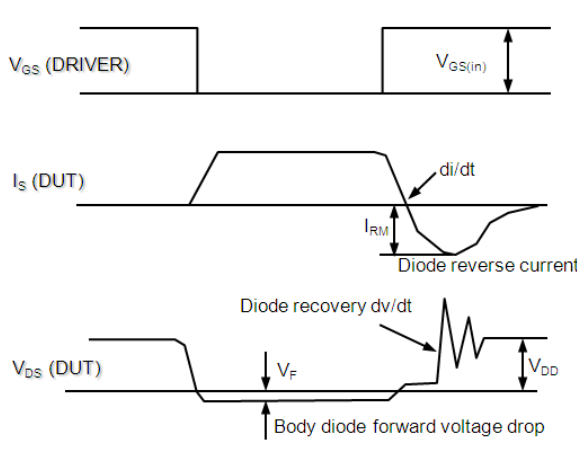
Test Circuit For Diode Recovery	Test Waveform For Diode Recovery
 *. dv/dt controlled by R_G *. I_S controlled by pulse period	

Table 16 Switching Time Characteristic

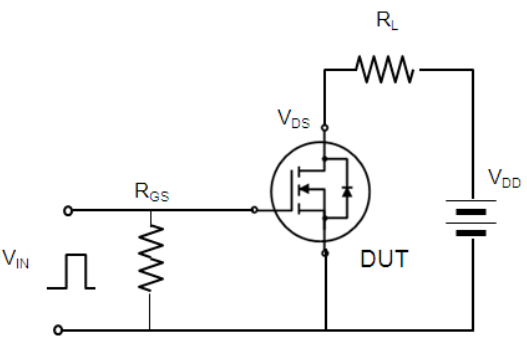
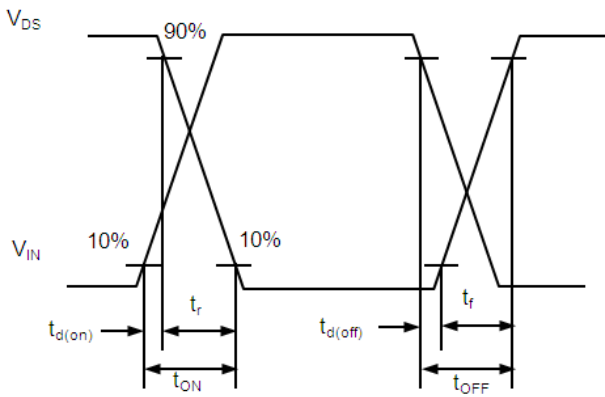
Test Circuit for Switching Time	Test Waveform for Switching Time
	

Table 17 Gate Charge Characteristic

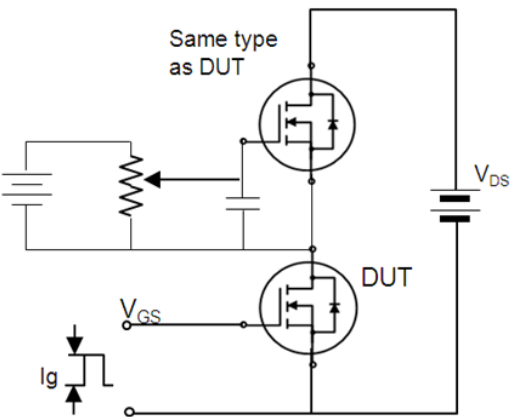
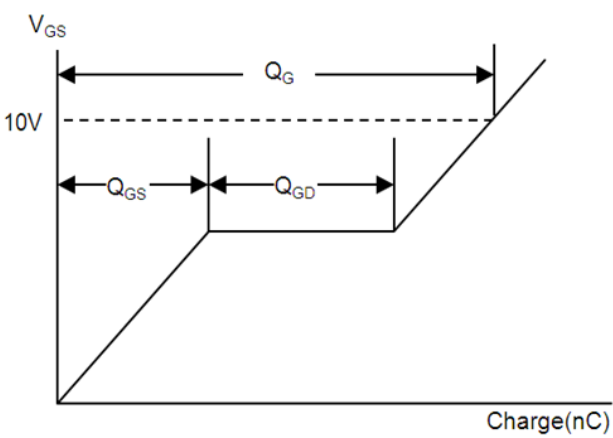
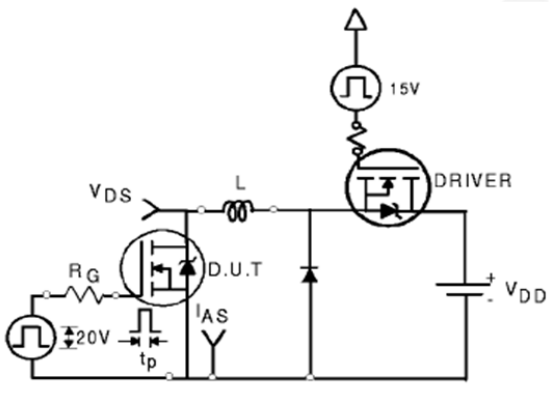
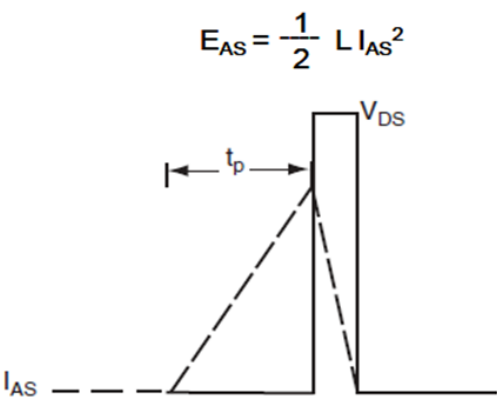
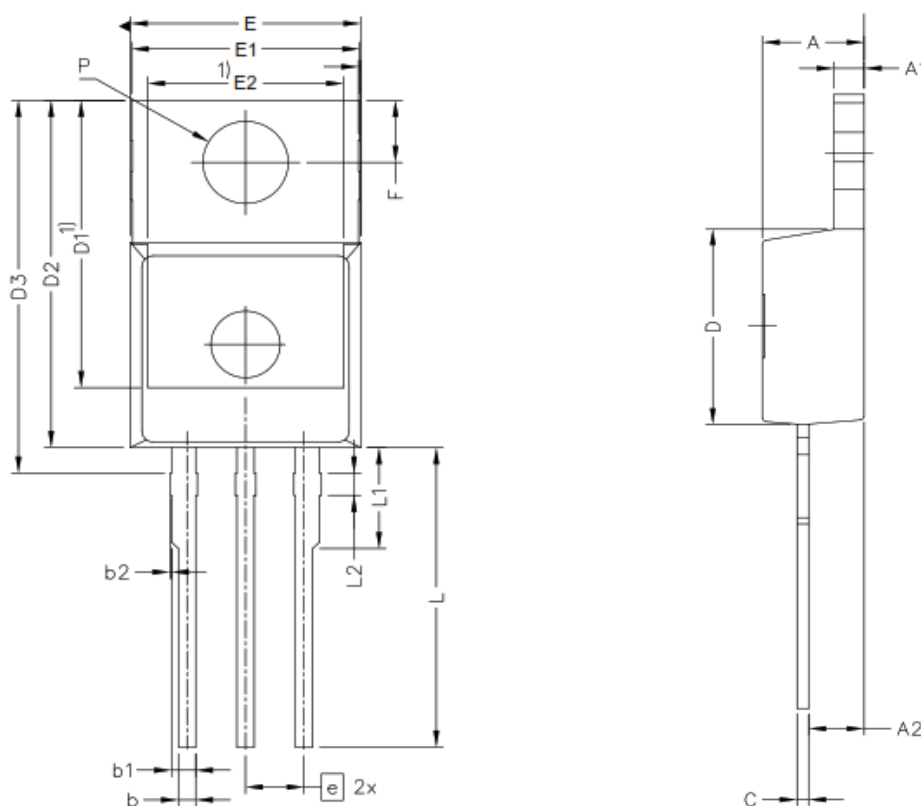
Test Circuit For Gate Charge	Test Waveform For Gate Charge
	

Table 18 Unclamped Inductive Characteristic

Test Circuit For Unclamped Inductive	Test Waveform For Unclamped Inductive
	

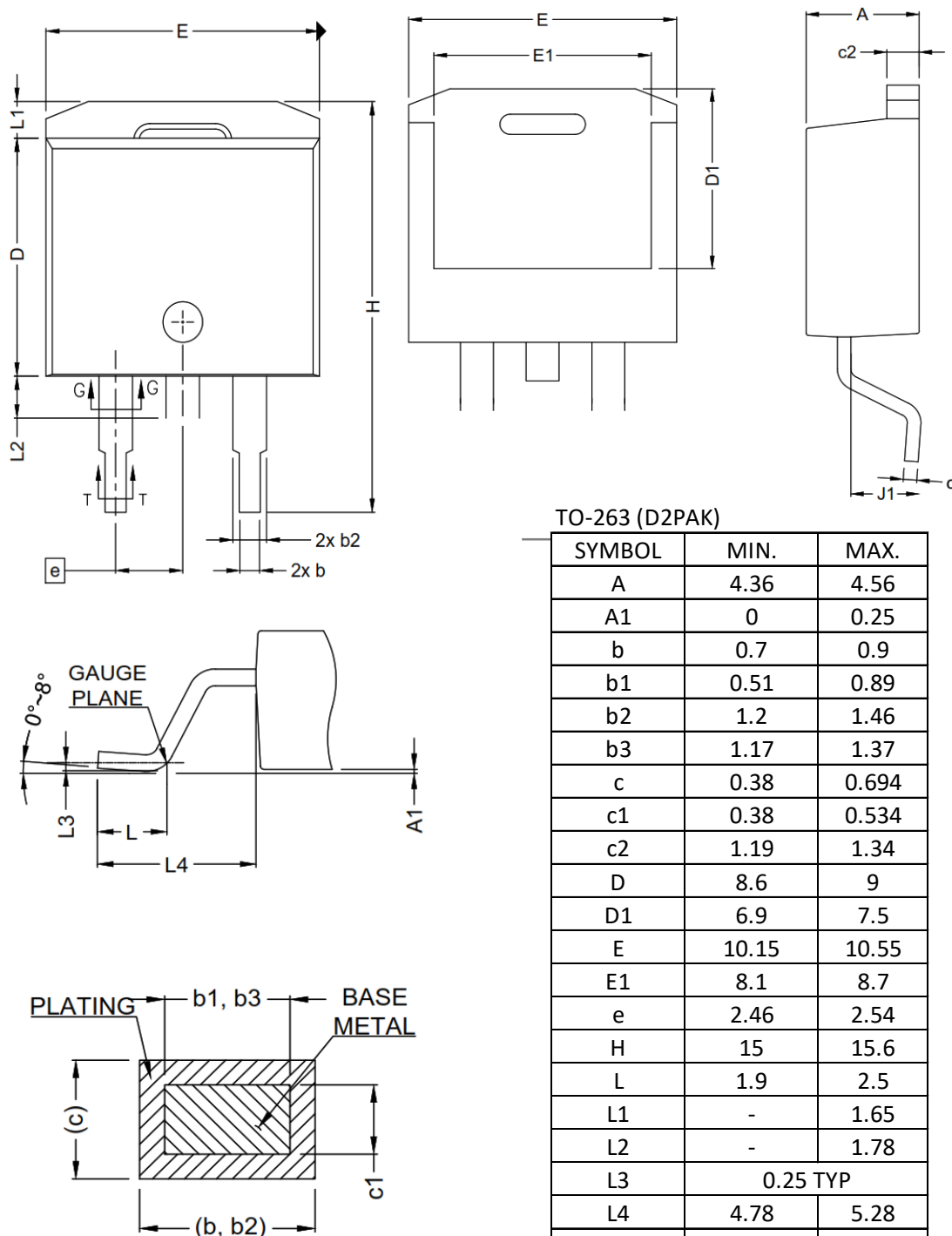
4a) TO-220



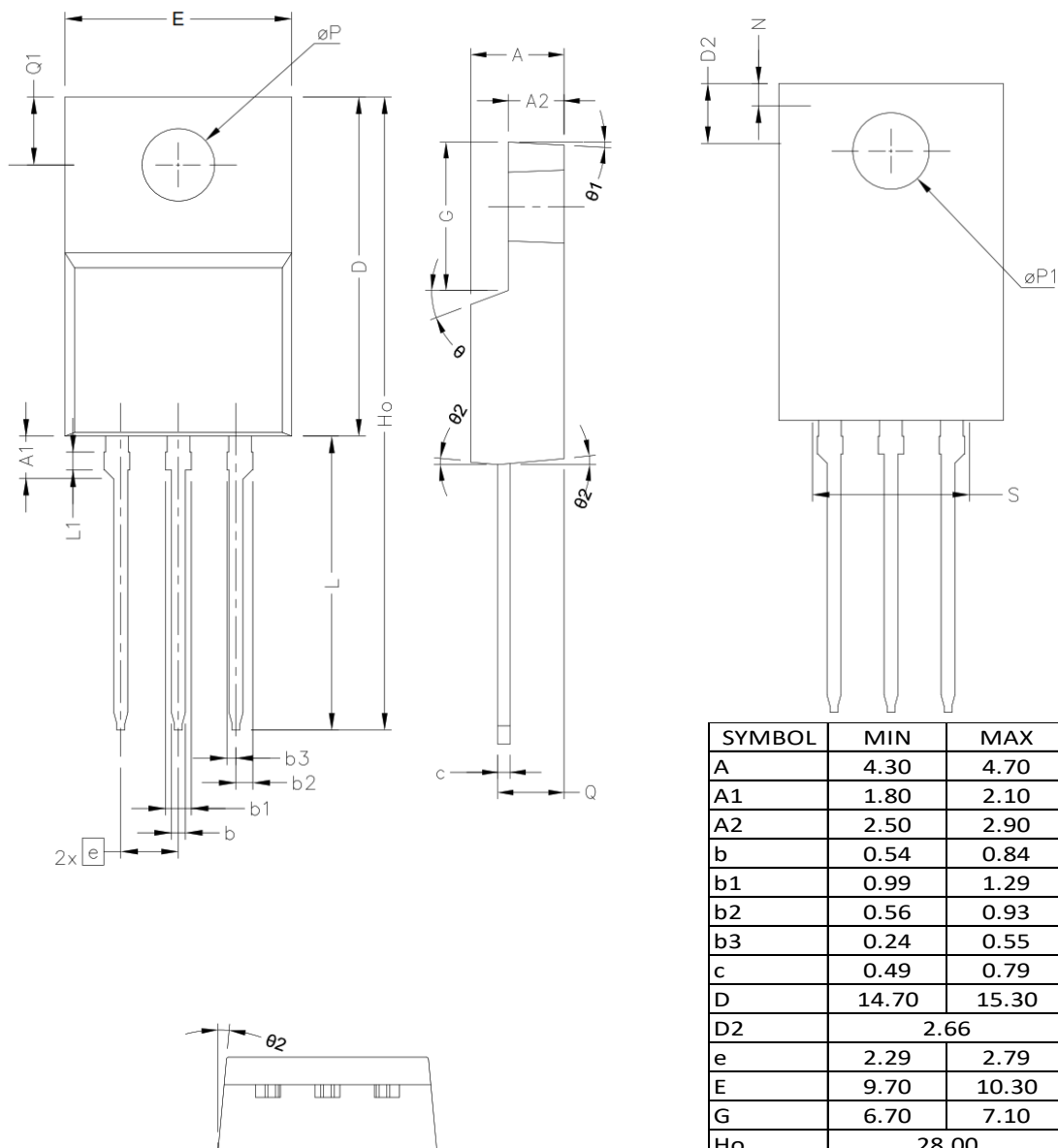
TO-220 3L

SYMBOL	MIN	MAX
A	4.20	4.60
A1	1.20	1.40
A2	2.20	2.60
b	0.65	0.85
b1	0.95	1.15
b2		0.15
C	0.40	0.60
D	9.05	9.45
D1	12.95	
D2	15.35	15.95
D3	16.50	17.10
E	9.80	10.20
E1	9.70	10.10
E2	8.50	
e	2.46	2.54
F	2.60	3.00
L	13.00	14.00
L1	4.35	4.75
L2	0.90	1.10
P	3.55	3.85

4b) TO-263



4C) TO-220 FullPak



SYMBOL	MIN	MAX
A	4.30	4.70
A1	1.80	2.10
A2	2.50	2.90
b	0.54	0.84
b1	0.99	1.29
b2	0.56	0.93
b3	0.24	0.55
c	0.49	0.79
D	14.70	15.30
D2	2.66	
e	2.29	2.79
E	9.70	10.30
G	6.70	7.10
Ho	28.00	
L	12.50	13.50
L1	0.70	0.90
N	2.86	
ϕP	3.05	3.40
$\phi P1$	3.40	
Q	3.10	3.30
Q1	2.70	3.30
S	7.00	
$\theta 1$	3 deg.	
$\theta 2$	5 deg.	

Revision History

Revision	Release Date	Comments
1.0	1-Dec 2017	Preliminary Datasheet Draft
2.0	2-Jan 2019	Characterization and enhancements

Resources

www.d3semi.com

Patents, Copyrights and Trademarks

U.S. and Foreign Patents Pending.

The following are trademarks and service marks owned by D3 Semiconductor:

D3 Semiconductor[®], “Flying D” [®], +FET, Defining Precision Power. All Trademarks are property of their respective owners. © D3 Semiconductor 2016. All rights reserved

Legal Disclaimer

The information in this document is provided solely regarding D3 Semiconductor (“D3”) products. The information is not a guarantee of performance or characteristics. D3 Semiconductor reserves the right to modify, change, amend, improve or make corrections to this document, and its products, at any time and its sole discretion without prior written consent or notice. No license to any intellectual property rights is granted or implied under this document. D3 Semiconductor disclaims warranties and liabilities of any kind including non-infringement of intellectual property rights of any third party. D3 Semiconductor products may be used in applications such as automotive, military, aerospace, medical or other applications where failure or malfunction may result in personal injury, death or severe property or environmental damage only with express written approval from D3 Semiconductor. Sale of D3 Semiconductor products are subject to D3 Semiconductor’s standard terms and conditions. Products not purchased through D3 Semiconductor’s authorized distributors, agents or sales representatives are void of warranty.

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

D3 Semiconductor:

[D3S0380N65E-U](#) [D3S0380N65B-U](#) [D3S380N65E-U](#) [D3S380N65B-U](#) [D3S380N65E-T](#) [D3S380N65F-U](#)